

<b>Notice of References Cited</b>	Application/Control No. 10/814,583	Applicant(s)/Patent Under Reexamination YEE, ALFRED A.	
	Examiner Gary Hartmann	Art Unit 3671	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,952,905	10-2005	Nickel et al.	52/711
	B	US-6,802,168	10-2004	Minnick, Larry A.	52/592.1
	C	US-6,659,677	12-2003	Exposito, Alejandro Rosales	403/24
	D	US-6,622,442	09-2003	Kwon, Heug Jin	52/259
	E	US-6,571,452	06-2003	Wang, Tien Fa	29/557
	F	US-6,058,672	05-2000	McClellan, Robert B.	52/587.1
	G	US-5,548,938	08-1996	Scheiwiller, Rene	52/604
	H	US-5,230,191	07-1993	Mayrand, Paul	52/309.12
	I	US-4,619,096	10-1986	Lancelot, III, Harry B.	52/726.1
	J	US-4,145,153	03-1979	Fasullo et al.	404/73
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	0 098 099	01-1984	Europe	Davison et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.